## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10584301	JENSEN ET AL.
Examiner	Art Unit
SHENG HAN	1793

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East search in US Pats, PG Pub, OCR, JPO, EPO and Derwent	5/6/2009	SH

INTERFERENCE SEARCH		
Subclass	Date	Examiner
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